Enhanced emission from ultra-thin long wavelength infrared superlattices on epitaxial plasmonic materials ©

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ABSTRACT

Molecular beam epitaxy allows for the monolithic integration of wavelength-flexible epitaxial infrared plasmonic materials with quantumengineered infrared optoelectronic active regions. We experimentally demonstrate a sixfold enhancement in photoluminescence from ultrathin (total thickness $\lambda_o/33$) long wavelength infrared (LWIR) superlattices grown on highly doped semiconductor "designer metal" virtual substrates when compared to the same superlattice grown on an undoped virtual substrate. Analytical and numerical models of the emission process via a dyadic Green's function formalism are in agreement with experimental results and relate the observed enhancement of emission to a combination of Purcell enhancement due to surface plasmon modes as well as directionality enhancement due to cavity-substrate-emitter interaction. The results presented provide a potential pathway toward efficient, ultrasubwavelength LWIR emitter devices, as well as a monolithic epitaxial architecture offering the opportunity to investigate the ultimate limits of light-matter interaction in coupled plasmonic/optoelectronic materials.

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The field of plasmonics centers around the generation and manipulation of hybrid electromagnetic/charge density waves supported at metal/dielectric interfaces.¹ Plasmonics' revival as a field of intense scientific interest approximately two decades ago² promised a litany of transformational advances in optics, sensing, and optoelectronics,³ the latter including surface plasmon enhanced sources, such as subdiffraction-limited lasers⁴⁻⁶ and ultraefficient emitters.⁷ However, the promised efficiency gains associated with plasmonic enhancement have largely been offset by the intrinsic losses of plasmonic materials,⁹ especially in the already high-optical-quality semiconductor platforms, which have been the beneficiaries of decades of research and development investment from the imaging, sensing, and telecom industries. The mid-IR, however, does not suffer from the affliction of extremely efficient emitters; quite the opposite, in fact. At these long wavelengths, a host of nonradiative recombination mechanisms (Shockley Read Hall, Auger, phonon-assisted, trap-assisted tunneling, etc.)¹⁰⁻¹⁴ conspire to severely limit radiative efficiency, with ever more pronounced effect as the wavelength of emission increases. The inherently low efficiency of mid-IR sources, though, offers very real room for improvement, which can potentially be realized with plasmonic materials engineered specifically for the mid-IR.

permittivity of the noble metals at longer wavelengths results in optical properties more closely resembling those of perfect electrical conductors (PECs) than plasmonic materials.¹⁵ The PEC-like nature of traditional plasmonic materials in the mid-IR precludes plasmonic phenomena such as subwavelength confinement of propagating or localized modes and, thus, many of the proposed benefits associated with plasmonics, including strongly enhanced light-matter interaction. At these wavelengths, however, highly doped semiconductors,^{16–19} particularly III-V alloys grown by molecular beam epitaxy (MBE), can demonstrate plasmonic behavior. These epitaxial mid-IR designer metals typically employ narrow bandgap materials such as InAs or InAsSb, whose small effective masses and potential for high doping concentrations allow for engineered plasma wavelengths across much of the mid-IR.^{20,21} The experimental reflection spectra associated with representative examples of such plasmonic semiconductor materials are shown in Fig. 1(a) (with growth details and parameter extraction listed in the supplementary material, Table S1, and an example fitting of the reflectance of one of these doped samples in Fig. S1). These materials, coincidentally, also serve as the materials of choice for the

While the noble metals (Au, Ag, etc.) are the plasmonic materials

of choice at visible and near-IR wavelengths, the large negative real

active regions of a broad range of mid-IR optoelectronic devices such as interband cascade lasers, superlattice-based emitters and detectors, and even nanostructured mid-IR quantum dot materials.^{22–27}

Of these, MBE-grown semiconductor superlattices (SLs) offer significant design flexibility for engineering absorbers or emitters across the mid-IR. These SLs consist of alternating layers of semiconductor alloys, where the layers are thin enough to allow the overlap of electron (and hole) states in neighboring quantum wells, and thus the formation of minibands in the conduction (and valence) bands, resulting in an effective engineered bandgap for the SL system. When the band offsets of the constituent layers are type-II, either staggered or broken gap, the effective bandgap of the type-II SL (T2SL) can be lower in energy than either of the constituent materials' bulk bandgaps. Such T2SLs offer the opportunity to engineer absorbing layers with narrow effective bandgaps and have been the subject of a large amount of interest for both their midwave IR (MWIR, 3-5 μ m) and long-wave IR (LWIR, 8–12 μ m) detection capabilities.^{28–33} However, SL materials, before the interest in T2SL detectors, were originally investigated as potential mid-IR emitters, with particular interest in the MWIR wavelength range.^{23,24,34} Unlike band-to-band or type-I emitters, these T2SL-based emitter structures are typically grown relatively thick $(1-2 \mu m)$ due to the reduced wavefunction overlap (as electron and hole wavefunctions are largely localized in alternating, adjacent layers). More recently, the significant wavelength flexibility inherent to the SL material system has led to interest in the use of these quantum engineered emitters for the development of LWIR sources.^{25,26} Figure 1(b) shows experimental low temperature photoluminescence (PL) from InAs/InAsSb SL emitters as a function of Sb composition, demonstrating this wavelength flexibility. Growth details and emission wavelengths for the T2SLs in Fig. 1(b) are listed in the supplementary material (Table S2). The ability to grow both epitaxial plasmonic materials and quantum engineered SL emitters across the LWIR allows for the investigation of coupled emitter/plasmonic systems in a single epitaxial growth. Control over the spectral position of emission and plasmonic behavior, together with the exquisite uniformity and spatial control offered by MBE, provides a unique system to investigate the near field interaction and enhancement of ultrathin quantum emitters

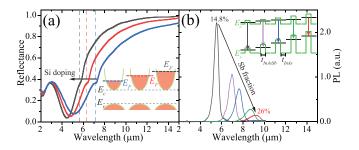


FIG. 1. (a) Reflectance spectra from three representative 500 nm InAsSb samples grown on GaSb with the increasing doping concentration, with the inset showing a schematic representation of the InAsSb valence band, conduction band, and Fermi level for the increasing doping concentration. The samples are measured at room temperature with an infrared microscope using an all-reflective Cassegrain objective. (b) Low temperature (79 K) photoluminescence spectra for five representation of single periods of the superlattices for the increasing Sb composition of the InAsSb laver.

by plasmonic surfaces. In this work, we demonstrate monolithic integration of an ultrathin quantum engineered LWIR emitter with an epitaxial plasmonic material and compare the optical properties of our structure to those of the same emitter, grown on undoped material.

The sample and control layer structures grown for this work are shown in Fig. 2(c). Our structures are grown by MBE on a p-type GaSb substrate following the growth of a GaSb buffer. The plasmonic (n⁺⁺) structure consists of a 500 nm thick Si:InAsSb layer, lattice-matched to GaSb, followed by a 255 nm thick InAs/InAsSb T2SL (14 periods), designed for an effective bandgap of 8.5 μ m, bookended by a pair of AlSb carrier blocking layers (10 nm each) to promote carrier confinement in the active region. For the control sample, we grow 500 nm of unintentionally doped (UID) InAsSb in place of the highly doped (n⁺⁺) InAsSb layer. The samples are capped with 10 nm of GaSb to prevent oxidization of the top AlSb layer. Note that the total thickness of the LWIR emitter active region is only 255 nm, or approximately $\lambda_o/33$, where λ_o is the free-space wavelength of the band edge emission from the SL emitter.

Figure 2(a) shows the experimental and fitted reflectance for both the n^{++} and UID virtual substrate samples, normalized to the near perfect reflectance of a Au surface. The optical properties of the n^{++} InAsSb are extracted from reflectance spectra of the as-grown sample (both reflection measurements and parameter extraction are detailed in the supplementary material). The experimental reflectance spectra are fitted using the transfer matrix method (TMM), treating the emitter as a high index dielectric and the doped layer as a Drude plasmonic material with permittivity,

$$\varepsilon_o(\omega) = \varepsilon_\infty \left(1 - \frac{\omega_p^2}{\omega^2 + i\gamma\omega} \right),\tag{1}$$

with fitting parameters ω_p , the screened plasma frequency, and γ , the free carrier scattering rate. From the fitting process, the highly doped layer's screened plasma wavelength ($\lambda_p = 2\pi c/\omega_p$) is estimated to be $\lambda_p = 6.7 \,\mu\text{m}$ and the scattering rate $\gamma = 10^{13}$ rads/s. Figure 2(b) shows the simulated electric field profile, for normal incidence reflection at $\lambda = 8.4 \,\mu\text{m}$, of both the undoped and doped samples. A significant increase in field strength is observed for the n⁺⁺ virtual substrate, associated with the formation of a leaky optical cavity in our optical stack. X-ray diffraction spectra and further growth details for both samples are provided in the supplementary material.

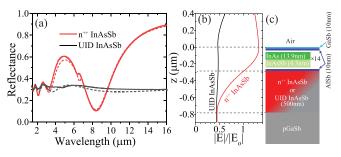


FIG. 2. (a) Experimental (solid) and modeled (dashed) reflectance of both the n⁺⁺ (red) and UID (black) InAsSb virtual substrate T2SL emitter samples. (b) Electric field profiles for normal incidence reflection at $\lambda = 8.4 \,\mu$ m showing the leaky cavity behavior of the stack with the n⁺⁺ virtual substrate. (c) Layer structures for the n⁺⁺ and UID InAsSb virtual substrate samples.

We investigate the emission efficiency enhancement of our ultrathin plasmonic emitter structure by Fourier transform infrared (FTIR) PL spectroscopy, using amplitude modulation step scan mode in order to eliminate the thermal background signal. PL spectra of the n⁺⁺ and UID InAsSb samples are shown in Fig. 3, for temperatures from 78 K to 297 K. Comparison of the PL spectra shows a clear (approximately sixfold) enhancement of emission intensity for the T2SL grown above the n⁺⁺ (plasmonic) InAsSb layer, when compared to emission from the T2SL grown on the UID InAsSb virtual substrate. Enhancement is observed for all temperatures and results in observable room temperature emission from the T2SL on the doped substrate, while the room temperature emission from the T2SL on the undoped substrate is at or below the system noise floor. Note that the undoped sample's PL spectrum includes a significant feature at $\lambda \sim 4 \,\mu m$ from the band edge luminescence of the InAsSb virtual substrate. The sample with the highly doped virtual substrate does not have a similar feature, as the nonradiative Auger scattering dominates recombination at such high doping concentrations.

The emitters are modeled using a dyadic Green's function formalism, incorporated into our TMM (code available in the supplementary material). In this approach, the field of a point dipole is first expanded in the (polarization-dependent) plane wave spectrum, parameterized by the components of the wavenumber parallel to the interfaces k_r . The TMM formalism is then used to calculate the effect of the reflections within the multilayer stack,^{35,36} followed by the numerical integration of the resulting spectrum. The approach allows for the calculation of two inter-related but separate quantities: the decay rate of the dipole emitter (a measure of the enhancement of the photonic density of states) and the angular profile of emission (a measure of multilayer-induced reshaping of dipole emission). The first of these quantities, given by the imaginary part of the Greens' function at the origin, represents the (orientation-specific) enhancement of the density of photonic states at the location of the dipole with respect to the density of photonic states in vacuum, a quantity also known as the Purcell factor (P),³

$$P = \frac{3}{2} \frac{Im(\vec{E} \cdot \vec{d})}{\omega^2 |d|^2},$$
(2)

with \vec{E} being the field generated by the point dipole \vec{d} at the location of the dipole. The enhancement of the density of photonic states

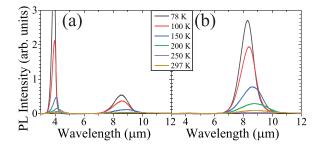


FIG. 3. Temperature dependent photoluminescence measured from the ultrathin T2SL emitters on both the (a) undoped and (b) highly doped virtual substrates. The $\lambda \sim 4 \,\mu m$ emission in (a) is the InAsSb band edge PL, which is quenched in (b) by the dominant Auger processes in the highly doped virtual substrate.

modifies the radiative decay rate for the dipole, in turn affecting its intrinsic quantum yield,

$$\tilde{q}_i = \frac{Pq_i}{1 + (P-1)q_i},\tag{3}$$

where q_i refers to the dipole's quantum yield (the ratio of the material's radiative recombination rate to total recombination rate) for the hypothetical isolated dipole in a vacuum. Figure 4(a) illustrates the positionand spectral-dependence of the Purcell factor in the sample with the plasmonic virtual substrate. As the Purcell factor is proportional to the electric field, this contour plot is a measure of the self-induced field strength at the dipole, as a function of dipole position and frequency, within the T2SL. It is clearly seen that enhancement of the density of photonic states is strongly correlated with the spectral position of the surface plasmon polariton (SPP) mode supported by the planar n⁺⁺ InAsSb/T2SL/air structure ($\lambda_{sp} = 9.4 \,\mu$ m), with the n⁺⁺ InAsSb playing the role of the plasmonic layer. Since the intrinsic quantum efficiency of SL emitters is known to be relatively low,²⁶ the Purcell effect significantly enhances the efficiency of the radiative decay of the T2SL. Figures 4(c)-4(e) illustrate the effective quantum yield (\tilde{q}_i) normalized to q_i of the dipole emitter within the T2SL for q_i 's spanning two orders of magnitude.

However, the enhancement of the quantum yield alone does not fully describe the overall enhancement of the experimentally observed emission. Because the "added" density of the photonic states comes from the guided SPP mode, peaking at λ_{sp} , the photons emitted into this guided mode are not out-coupled into free space modes and therefore do not contribute to the far-field emission of the overall structure. To capture the full experimentally observed enhancement, we need to understand not only multilayer-induced changes in the density of photonic modes but also the multilayer-induced changes in the angular profile of the emission pattern of the dipole. To accomplish the latter task, we calculate the \hat{z} -component of the Poynting flux density emitted by the dipole (S_z), which clarifies the spatial and spectral properties

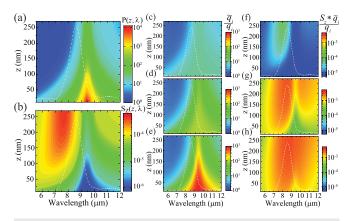


FIG. 4. Modeling emission from the LWIR T2SL grown above the n⁺⁺ substrate. Contour plots of the dipole emitter (a) Purcell factor (P, on a logarithmic color scale) and (b) S_z vs wavelength and position. Contour plots of the effective quantum yield (\tilde{q}_i) on a logarithmic color scale) normalized to the q_i vs position and wavelength for (c) $q_i = 10^{-1}$, (d) $q_i = 10^{-2}$, and (e) $q_i = 10^{-3}$. The product $S_z * \tilde{q}_i$ normalized to q_i (on a logarithmic color scale) vs position and wavelength for (f) $q_i = 10^{-1}$, (g) $q_i = 10^{-2}$, and (h) $q_i = 10^{-3}$. The low temperature PL spectrum from the UID substrate T2SL is overlaid on each plot as a white dashed line.

of the emission. In our calculations, the above quantity is normalized to remain independent of the emission frequency and of the local Purcell factor and includes only emission angles $|\theta| \leq 15^{\circ}$ from the normal, mimicking our experimental conditions. The behavior of the Poynting flux captures the effect of the directionality/reflectivity reshaping of the emitted light due to the multiple reflections in the optical stack (optical cavity) surrounding the dipole. The distribution of the Poynting flux density as a function of the emission frequency and the location of the dipole within our structures is illustrated in Fig. 4(b). Notably, there is a clear anticorrelation between the Purcell enhancement and the density of modes out-coupled into the far field, which illustrates the fact that the dipoles located close to the metal interface primarily emit into guided (and highly lossy) plasmonic modes. The overall enhancement of emission is then proportional to the product of the quantum yield and the cavity-corrected Poynting flux density, $S_z * \tilde{q}_i$, normalized to the intrinsic quantum efficiency (q_i) , shown in Figs. 4(f)-4(h). From this product, we can see that the spectral regions of maximal enhancement of radiation come from the "compromise" between the maximal Purcell effect and the maximal outcoupling efficiency. Moreover, the enhancement is stronger in systems with smaller q_i .

The effective conduction and valence bands of the T2SLs mirror, in many ways, a bulk semiconductor and therefore do not possess a preferential orientation for the optical dipole matrix elements for (effective) band-to-band transitions. Thus, optical transitions in these superlattices are not constrained by the same polarization rules as those for intersubband transitions. Therefore, to calculate the final predicted emission spectrum, we assume that the point dipole emitters are homogeneously distributed across the T2SL layer, with randomly distributed orientations, and have a distribution of emission frequencies $A(\omega)$ described by the PL spectrum from the UID substrate T2SL [the black solid line in Fig. 3(a) and the white dashed overlays in Fig. 4]. The overall measurable far-field emission is then given by $S_{tot} = \langle \tilde{q}_i A(\omega) S_z \rangle$, with $\langle \dots \rangle$ representing an average over the spatial location and orientations of the dipole. The experimental and predicted emission (for $q_i = 0.02$) is shown in Fig. 5(a). As one can clearly see, the calculations predict the observed PL enhancement (PLE) of the emission with remarkable accuracy and the spectral position of the enhanced emission to within a fraction of a micrometer. This minimal discrepancy between modeled and experimental spectra is most likely a result of the slight sample-to-sample variation of our T2SL growths, as the predicted emission from the T2SL on the n⁺⁺ virtual substrate is modeled using the emission from the T2SL on the UID substrate. Parameters \tilde{q}_i and S_z represent two (related) sources of emission enhancement in the multilayer stacks: efficiency reshaping of emission caused by the Purcell effect and "cavity"like directionality reshaping caused by the layered environment. While the two parameters are not completely independent, they can be optimized in a semiindependent manner. Therefore, the results presented in this work should be treated as a low-bound estimate of the true potential of the PLE in IR systems that could be improved by, for example, patterning the top surface of the structure. Figure 5(b) shows the integrated PL intensity as a function of temperature for the T2SLs on the UID (black) and n⁺⁺ (red) virtual substrates. As temperature is increased, a dramatic decrease in emission is expected and observed for both samples (an approximately twenty-fold decrease in integrated PL), resulting from increased nonradiative recombination rates (predominantly

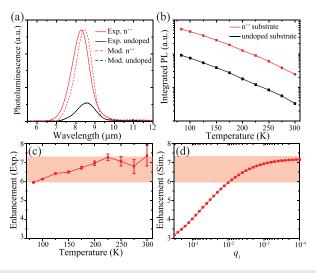


FIG. 5. (a) Modeled (dashed, assuming $q_i = 0.02$) and experimental (solid) PL from the LWIR T2SL grown on n⁺⁺ (red) and UID (black) virtual substrates. (b) Integrated PL as a function of temperature for the T2SL on the n⁺⁺ (red) and UID (black) virtual substrates. An approximately twenty-fold decrease in integrated PL is observed for the samples from T = 80 K to T = 300 K. (c) The measured enhancement, $PLE = \int PL_{n^+} d\omega / \int PL_{UID} d\omega$, as a function of temperature. (d) Modeled PLE, for $q_i = 0.31$ to $q_i = 10^{-4}$. Shaded regions in (c) and (d) correspond to the range of experimentally observed PLE.

from increasing Auger recombination).³⁸ This decrease in emission intensity can be thought of as a temperature-dependent change in the q_i of the T2SLs, offering a mechanism for exploring the observed and predicted PLE as a function of emitter efficiency. Thus, the experimental enhancement of emission resulting from the n⁺⁺ virtual substrate is plotted as a function of temperature in Fig. 5(c), and we observe a largely monotonic increase in enhancement with increasing temperature (decreasing efficiency). In Fig. 5(d), we plot the calculated PLE as a function of the modeled dipole's q_i . Our model predicts an increase in enhancement with decreasing q_{i} , as expected, with the enhancement saturating at approximately a factor of seven for the structures investigated in this work. Comparing the experimental PLE to the modeled PLE suggests that our LWIR T2SLs have q_i of 2% at low temperature and between 0.02% and 0.2% at high temperatures (~300 K), in line with expected q_i of LWIR T2SL materials.²⁶ Such a decrease in q_i of our emitters agrees with the experimentally observed decrease in integrated PL as a function of temperature observed in Fig. 5(b). Though correlating the x-axes of Figs. 5(c) and 5(d) would require the measurement of the minority carrier lifetimes (not possible due to the weak emission above 100 K), the experimental data provide qualitative agreement with the predictions from theory and offer insight into the achievable enhancement for LWIR emitters of varying intrinsic efficiencies. The mid-IR, and in particular, the LWIR, where efficient emitters are severely lacking, offers the opportunity for significant enhancement of emission by combining quantum engineered mid-IR emitters with designer semiconductor plasmonic metals. In this work, we demonstrate monolithic integration of an ultrathin LWIR emitter and epitaxial plasmonic material, as well as the commensurate sixfold emission enhancement of the SL emitter relative to the

same SL grown on a nonplasmonic material. We use a theoretical model of the emission based on a dyadic Green's function and TMM formalisms to provide a quantitative explanation of the emission enhancement phenomenon as an interplay between Purcell enhancement and emitter-cavity interaction. Assuming $q_i = 0.02$ for our emitters, our model accurately reproduces the emission enhancement observed in experiments. Moreover, the model accurately predicts the increasing PLE for decreasing q_i . The LWIR emitters demonstrated in this work offer an approach to infrared emitter design, where plasmonic materials are implemented, and grown monolithically, with mid-IR active regions for ultrathin mid-IR sources. In addition, the ability to engineer both the plasmonic materials' properties, the active regions' optical transitions, and (at atomic scale) the geometry of the coupled system, offers a powerful tool-box for the investigation of light-matter interaction with extreme spectral and spatial precision.

See the supplementary material for the reflectivity and extracted permittivity plots from a doped InAsSb layer, tables with growth details and extracted optical properties of the T2SLs and doped InAsSb samples in Figs. 1(a) and 1(b), and XRD spectra of the T2SL samples on the doped and undoped virtual substrates. Additionally, we provide the code for the dyadic Green's function calculations used in this work.

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